Bidirectional high-side power switch for charger and USB-OTG applicationsRev. 2.0 — 17 May 2023Product data sheet

1 General description

The NX5P3001 is an advanced bidirectional power switch and ESD-protection device for combined USB-OTG and charger port applications. It includes undervoltage lockout, overvoltage lockout and overtemperature protection circuits designed to automatically isolate the power switch terminals when a fault condition occurs.

The device features two power switch input/output terminals (VBUSI and VBUSO), an open-drain acknowledge output (ACK), an enable input which includes logic level translation (EN) and low capacitance Transient Voltage Suppression (TVS) type ESD-clamps for USB data and ID pins.

When EN is set HIGH the device enters a low-power mode, disabling all protection circuits. When used in combined charger and USB-OTG applications the 30 V tolerant VBUSI switch terminal is used as the supply and switch input when charging, for USB-OTG the VBUSO switch terminal is used as the supply and switch input.

Designed for operation from 3.2 V to 6.35 V, it is used in battery charging and power domain isolation applications to reduce power dissipation and extend battery life.

2 Features and benefits

- 30 V tolerant VBUSI supply pin
- Wide supply voltage range from 3.2 V to 6.35 V
- Automatic switch operation for charging within the supply range
- I_{SW} maximum 3 A continuous current
- Low ON resistance: 62 m Ω (typical) at a supply voltage of 5.0 V
- 1.8 V control logic input to open the switch
- Soft start turn-on slew rate
- Protection circuitry
 - Overtemperature protection
 - Overvoltage lockout
 - Undervoltage lockout
- ESD protection:
 - HBM ANSI/ESDA/JEDEC JS-001 Class 2 exceeds 2 kV
 - CDM AEC standard Q100-01 (JESD22-C101E)
 - IEC61000-4-2 contact discharge exceeds 8 kV for pins VBUSI, D-, D+ and ID
- Specified from -40 °C to +85 °C

3 Applications

- Smart and feature phones
- Tablets, eBooks



4 Ordering information

Table 1. Ordering information

Type number	Package	ackage								
	Temperature range	Name	Description	Version						
NX5P3001UK	-40 °C to +85 °C		wafer level chip-scale package, 12 bumps; body 1.36 × 1.66 × 0.51 mm (Backside Coating included)	NX5P3001						

5 Marking

Table 2. Marking codes					
Type number	Marking code				
NX5P3001UK	X05P3				

6 Functional diagram



7 Pinning information

7.1 Pinning



7.2 Pin description

Table 3. Pin description

Symbol	Pin	Description
VBUSO	A3, B2, B3	VBUSO (output/input supply)
VBUSI	A1, A2, B1	VBUSI (input supply/output)
АСК	C1	acknowledge condition indicator (open-drain output)
GND	C2	ground (0 V)
EN	C3	enable input (active LOW)
D-	D1	ESD-protection I/O
D+	D2	ESD-protection I/O
ID	D3	ESD-protection I/O

8 Functional description

Tuble -										
EN	VBUSI	VBUSO	ACK	Operation mode						
L	< 3.2 V	< 3.2 V	Z	undervoltage lockout; switch open						
L	3.2 V < VBUSI < 6.35 V	< 3.2 V	Z	enabled; switch closed; charging mode						
L	< 3.2 V	> 3.2 V	Z	enabled; switch closed; OTG mode						
L	Х	X	0	overtemperature protection; switch open						
L	> 6.35 V	X	0	overvoltage lockout; switch open						
Н	Х	X	Z	disable; switch open						

Table 4. Function table^[1]

[1] H = HIGH voltage level; L = LOW voltage level, Z = high-impedance OFF-state.

8.1 EN-input

A HIGH on EN disables the N-channel MOSFET and all protection circuits putting the device into a low-power mode. A LOW on EN enables the protection circuits and then the N-channel MOSFET.

8.2 Undervoltage lockout

When \overline{EN} is LOW and VBUSI and VBUSO < 3.2 V, the UnderVoltage LockOut (UVLO) circuits disable the Nchannel MOSFET. Once VBUSI or VBUSO > 3.3 V and no other protection circuits are active, the state of the Nchannel MOSFET is controlled by the \overline{EN} pin.

8.3 Overvoltage lockout

When \overline{EN} is LOW and VBUSI > 6.35 V, the OverVoltage LockOut (OVLO) circuit disables the N-channel MOSFET and sets the ACK output LOW. Once VBUSI < 6.25 V and no other protection circuits are active, ACK is set high impedance and the state of the N-channel MOSFET is controlled by the \overline{EN} pin.

8.4 Overtemperature protection

When EN is LOW and the device temperature exceeds 125 °C the overtemperature protection (OTP) circuit disables the N-channel MOSFET and set the ACK output LOW. Once the device temperature decreases to below 115 °C and no other protection circuits are active, ACK is set high impedance and the state of the N-channel MOSFET is controlled by the EN pin.

8.5 ACK output

The ACK output is an open-drain output that requires an external pull-up resistor. If OVLO or OTP circuits are activated the ACK output is set LOW to indicate that a fault has occurred. The ACK output will return to high impedance state automatically once the fault condition is removed or EN is HIGH.

9 Application diagram

The NX5P3001 typically connects a USB port in a portable, battery operated device. The ACK signal requires an additional external pull-up resistor which should be connected to a supply voltage matching the logic input pin supply level it is connected to.

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Limiting values 10

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		Min	Max	Unit
VI	input voltage	VBUSI	[1]	-0.5	+32	V
		VBUSO	[1]	-0.5	+6.75	V
		EN	[2]	-0.5	+6.0	V
		D-, D+, ID	[1]	-0.5	+6.0	V
Vo	output voltage	ACK		-0.5	+6.0	V
I _{IK}	input clamping current	<u>EN</u> : V _I < -0.5 V		-50	-	mA
I _{SK}	switch clamping current	VBUSI; VBUSO; V _I < -0.5 V		-50	-	mA
I _{SW}	switch current	T _{amb} = 85 °C		-	3	A
T _{j(max)}	maximum junction temperature			-40	+125	°C
T _{stg}	storage temperature			-65	+150	°C
P _{tot}	total power dissipation	T _{amb} = -40 °C to +85 °C				
		WLCSP12 package	[3]		1.44	W

The minimum and maximum switch voltage ratings may be exceeded if the switch clamping current rating is observed. [1]

[2] [3] The minimum input voltage rating may be exceeded if the input current rating is observed.

For WLCSP12 package: Ptot derates linearly with 13.7 mW/K above 20 °C.

Recommended operating conditions 11

Table 6. Recommended operating conditions

Symbol	Parameter	Conditions	Min	Мах	Unit
VI	input voltage	VBUSI	3.0	30	V
		VBUSO	3.0	5.5	V
		EN	0	5.5	V

Table 6. Recommended operating conditions...continued

Symbol	Parameter	Conditions	Min	Мах	Unit
V _{I/O}	input/output voltage	D-, D+, ID	0	5.5	V
T _{amb}	ambient temperature		-40	+85	°C

12 Thermal characteristics

Table 7. Thermal characteristics

Symbol	Parameter	Conditions		Тур	Unit
R _{th(j-a)}	thermal resistance from junction to ambient		[1][2]	73	K/W

[1] The overall Rth(j-a) can vary depending on the board layout. To minimize the effective Rth(j-a), all pins must have a solid connection to larger Cu layer areas e.g. to the power and ground layer. In multi-layer PCB applications, the second layer should be used to create a large heat spreader area right below the device. If this layer is either ground or power, it should be connected with several vias to the top layer connecting to the device ground or supply. Try not to use any solder-stop varnish under the chip.

[2] Please rely on the measurement data given for a rough estimation of the Rth(j-a) in your application. The actual Rth(j-a) value may vary in applications using different layer stacks and layouts

13 Static characteristics

Table 8. Static characteristics

 $V_{I(VBUSx)}$ = 4.0 V to 5.5 V^[1]; unless otherwise specified; Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		Т	amb = 25	5 °C	T _{amb} = -40 °	C to +85 °C	Unit
				Min	Typ ^[2]	Мах	Min	Max	
V _{IH}	HIGH-level input voltage	EN		1.2	-	-	1.2	-	V
V _{IL}	LOW-level input voltage	EN		-	-	0.4	-	0.4	V
V _{OL}	LOW-level output voltage	ACK; I _O = 8 mA		-	-	0.5	-	0.5	V
R _{pu}	pull-up resistance	ACK		10	-	200	10	200	kΩ
V _{pu}	pull-up voltage	ACK		1.65	-	5.5	1.65	5.5	V
I _{GND}	ground current	EN = LOW; I _O = 0 A; see Figure 6 to Figure 11		-	280	-	-	400	μA
		EN = HIGH; I _O = 0 A; see Figure 6 to Figure 11			8			16	μA
$I_{S(OFF)}$	OFF-state leakage current	$V_{I(VBUSI)} = 5.5 V; V_{I(VBUSO)} = 0 V to 5 V; see Figure 12$	[3]	-	0.1	-	-	6.5	μA
		V _{I(VBUSO)} = 5.5 V; V _{I(VBUSI)} = 0 V to 30 V; see <u>Figure 13</u>	[4]	-	0.1	-	-	8.5	μA
V _{UVLO}	undervoltage lockout voltage	VBUSI; VBUSO; EN = LOW		3.0	3.2	3.4	3.0	3.4	V
V _{hys(UVLO)}	undervoltage lockout hysteresis voltage	VBUSI; VBUSO; EN = LOW		-	100	-	-	-	mV
V _{OVLO}	overvoltage lockout voltage	VBUSI; EN = LOW		6.1	6.35	6.8	6.1	6.8	V

Table 8. Static characteristics...continued

 $V_{I(VBUSx)}$ = 4.0 V to 5.5 V^[1]; unless otherwise specified; Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		T _{amb} = 25 °C			T _{amb} = -40 °C	Unit	
				Min	Typ ^[2]	Max	Min	Мах	
V _{hys(OVLO)}	overvoltage lockout hysteresis voltage	VBUSI; EN = LOW		-	100	-	-	-	mV
C _{I/O}	input/output capacitance	D-; D+; ID; V _{I(VBUSx)} = 5.5 V	[1]	-	3	-	-	-	pF
CI	input capacitance	EN		-	3	-	-	-	pF
C _{S(ON)}	ON-state capacitance	VBUSI; VBUSO		-	-	0.5	-	0.5	nF

VBUSx is the supply voltage associated with the input, either VBUSI or VBUSO. All typical values are measured at $V_{I(VBUSx)} = 5.0$ V unless otherwise specified. Typical value is measured at $V_{I(VBUSO)} = 0$ V. Typical value is measured at $V_{I(VBUSI)} = 0$ V.

[1] [2] [3] [4]

13.1 Graphs



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13.2 ON resistance

Table 9. ON resistance

At recommended operating conditions; voltages are referenced to GND (ground = 0 V)

Symbol	Parameter	Conditions	T _{amb} = 25 °C		T _{amb} = -40 °	Unit			
				Min	Тур	Мах	Min	Мах	
R _{ON}	ON resistance	V _{I(VBUSx)} = 4.0 V to 5.5 V; see Figure 14 to Figure 18	[1]						
		I _{LOAD} = 200 mA		-	62	-	40	100	mΩ
		I _{LOAD} = 1.5 A		-	62	-	40	100	mΩ

[1] VBUSx is the supply voltage associated with the input, either VBUSI or VBUSO.

13.3 ON resistance test circuit and graphs



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14 Dynamic characteristics

Table 10. Dynamic characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); for test circuit see Figure 20.

Symbol	Parameter	Conditions	Ta	_{mb} = 25	°C	T _{amb} = -40 °C	Unit	
			Min	Тур	Мах	Min	Мах	
t _{en}	enable time	EN to VBUSO; see Figure 19 and Figure 21 to Figure 24						

Table 10. Dynamic characteristics...continued

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); for test circuit see Figure 20.

Symbol	Parameter	Conditions	T,	T _{amb} = 25 °C		T _{amb} = -40 °C	C to +85 °C	Unit
			Min	Тур	Max	Min	Max	
		V _{I(VBUSI)} = 4.0 V	-	500	-	210	-	μs
		V _{I(VBUSI)} = 5.5 V	-	500	-	200	-	μs
		EN to VBUSI; see Figure 19 and Figure 21 to Figure 24						
		V _{I(VBUSO)} = 4.0 V	-	500	-	310	-	μs
		V _{I(VBUSO)} = 5.5 V	-	500	-	290	-	μs
t _{dis}	disable time	EN to VBUSO; see Figure 19and Figure 25 to Figure 28						
		V _{I(VBUSI)} = 4.0 V	-	1.6	-	-	-	ms
		V _{I(VBUSI)} = 5.5 V	-	1.6	-	-	-	ms
		EN to VBUSI; see <u>Figure 19</u> and <u>Figure 25</u> to <u>Figure 28</u>						
		V _{I(VBUSO)} = 4.0 V	-	1.6	-	-	-	ms
		V _{I(VBUSO)} = 5.5 V	-	1.6	-	-	-	ms
t _{on}	turn-on time	EN to VBUSO; see Figure 19						
		V _{I(VBUSI)} = 4.0 V	-	1500	-	880	-	μs
		V _{I(VBUSI)} = 5.5 V	-	1600	-	920	-	μs
		EN to VBUSI; see Figure 19						
		V _{I(VBUSO)} = 4.0 V	-	1500	-	820	-	μs
		V _{I(VBUSO)} = 5.5 V	-	1700	-	880	-	μs
t _{off}	turn-off time	EN to VBUSO; see Figure 19						
		V _{I(VBUSI)} = 4.0 V	-	34.6	-	-	-	ms
		V _{I(VBUSI)} = 5.5 V	-	34.6	-	-	-	ms
		EN to VBUSI; see Figure 19						
		$V_{I(VBUSO)} = 4.0 V$	-	34.6	-	-	-	ms
		$V_{I(VBUSO)}$ = 5.5 V	-	34.6	-	-	-	ms
t _{TLH}	TLH LOW to	VBUSO; see Figure 19						
	HIGH output transition time	$V_{I(VBUSI)} = 4.0 V$	-	1000	-	670	-	μs
		$V_{I(VBUSI)} = 5.5 V$	-	1100	-	720	-	μs
		VBUSI; see <u>Figure 19</u>						
		$V_{I(VBUSO)} = 4.0 V$	-	1000	-	510	-	μs
		V _{I(VBUSO)} = 5.5 V	-	1200	-	590	-	μs
t _{THL}	HIGH to	VBUSO; see Figure 19						
	LOW output transition time	V _{I(VBUSI)} = 4.0 V	-	33.0	-	-	-	ms
		V _{I(VBUSI)} = 5.5 V	-	33.0	-	-	-	ms

Table 10. Dynamic characteristics...continued

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); for test circuit see Figure 20.

Symbol	Parameter	Conditions		T _{amb} = 25 °C		T _{amb} = -40 °C to +85 °C		Unit	
				Min	Тур	Мах	Min	Мах	
		VBUSI; see Figure 19							
		V _{I(VBUSO)} = 4.0 V		-	33.0	-	-	-	ms
		V _{I(VBUSO)} = 5.5 V		-	33.0	-	-	-	ms

14.1 Waveforms and test circuit



Figure 19. Switching times

Table 11. Measurement points

Supply voltage	EN Input	Output	
VBUSx	V _M	V _X	V _Y
4.0 V to 5.5 V	$0.5 \times V_{I(EN)}$	0.1 × V _{OH}	0.9 × V _{OH}



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NX5P3001

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15 Package outline



Figure 29. Package outline WLCSP12 package

16 Abbreviations

Table 13. Abbrev	viations
Acronym	Description
CDM	Charged Device Model
DUT	Device Under Test
ESD	ElectroStatic Discharge
НВМ	Human Body Model
MOSFET	Metal-Oxide Semiconductor Field Effect Transistor
OTP	OverTemperature Protection
USB-OTG	Universal Serial Bus On-The-Go
UVLO	UnderVoltage LockOut
OVLO	OverVoltage LockOut

17 Revision history

Table 14. Revision	n history			
Document ID	Release date	Data sheet status	Change notice	Supersedes
NX5P3001 v.2	20230517	Product data sheet	-	NX5P3001 v.1
Modifications:	Updated packa	age outline max/nom/mir	dimensions for 'b'	
NX5P3001 v.1	20130911	Product data sheet	-	-

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18.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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Bidirectional high-side power switch for charger and USB-OTG applications

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